


<b>Search Notes</b>  	<b>Application/Control No.</b>  10575174	<b>Applicant(s)/Patent Under Reexamination</b>  MIURA, YUKI
	<b>Examiner</b>  KYLE R STORK	<b>Art Unit</b>  2178

SEARCHED			
Class	Subclass	Date	Examiner
715	234, 243, 254	9/28/08	
715	234, 243, 254	3/6/09	
715	234, 243, 254	10/12/09	
715	234, 243, 254	8/4/10	
715	234, 243, 254	1/5/11	
715	234, 243, 254	6/16/11	
715	234, 243, 254	11/9/11	

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (USPat, USPG-Pub)	9/28/08	
NPL Search (IEEE, ACM, Google)	9/28/08	
Inventor Name Search	9/28/08	
Update EAST Search (USPat, USPG-Pub)	4/6/09	
Update NPL Search (IEEE, ACM, Google)	4/6/09	
Update EAST Search (USPat, USPG-Pub)	10/12/09	
Update EAST Search (USPat, USPG-Pub)	8/4/10	
Update EAST Search (USPat, USPG-Pub)	1/5/11	
Update EAST Search (USPat, USPG-Pub)	6/16/11	
Update NPL Search (Google, Google Scholar, Multi-Search)	6/16/11	
Update EAST Search (USPat, USPG-Pub, USOCR, EPO, Derwent, IBM_TDB)	11/9/11	
Update NPL Search (Google, Google Scholar)	11/9/11	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/K. R. S./ Primary Examiner.Art Unit 2178
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